ON Semiconductor

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Power MOSFET Dual P-Channel ChipFET™

3.0 Amps, 8 Volts

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package

Applications

• Power Management in Portable and Battery-Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

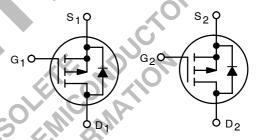
Rating	Symbol	5 secs	Steady State	Unit		
Drain-Source Voltage	V _{DS}	-8	3.0	V		
Gate-Source Voltage	V _{GS}	±ŧ	3.0	V		
Continuous Drain Current $(T_J = 150^{\circ}C)$ (Note 1) $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	ID	±4.1 ±2.9	±3.0 ±2.2	A		
Pulsed Drain Current	I _{DM}	±	10	Α		
Continuous Source Current (Diode Conduction) (Note 1)	ls	-1.8	-0.9	C _A		
Maximum Power Dissipation (Note 1) T _A = 25°C T _A = 85°C	P _D	2.1 1.1	1.1 0.6	W		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to	+150	°C		
Surface Mounted on 1" x 1" FR4 Board.						



ON Semiconductor®

http://onsemi.com

DUAL P-CHANNEL 3.0 AMPS, 8 VOLTS $R_{DS(on)} = 90 \text{ m}\Omega$



Channel MOSFET

P-Channel MOSFET



ChipFET CASE 1206A STYLE 2

MARKING PIN CONNECTIONS DIAGRAM S₁ D_1 2 G₁ 2 [D_2 3 S2 3 6 D_2 4 G_2 5

A9 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping			
NTHD5905T1	ChipFET	3000/Tape & Reel			

1

THERMAL CHARACTERISTICS

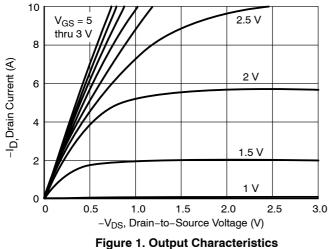
Characteristic	Symbol	Тур	Max	Unit
Maximum Junction-to-Ambient (Note 2) t ≤ 5 sec Steady State	R _{thJA}	50 90	60 110	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R_{thJF}	30	40	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static						
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-0.45	-	-	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8.0 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -6.4 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1.0	μΑ
		$V_{DS} = -6.4 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$	-	-	-5.0	
On-State Drain Current (Note 3)	I _{D(on)}	$V_{DS} \le -5.0 \text{ V}, V_{GS} = -4.5 \text{ V}$	-10	- , (<u>-</u>	Α
Drain-Source On-State Resistance (Note 3)	r _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -3.0 \text{ A}$	-	0.075	0.090	Ω
		$V_{GS} = -2.5 \text{ V}, I_D = -2.5 \text{ A}$	-	0.110	0.130	
		$V_{GS} = -1.8 \text{ V}, I_D = -1.0 \text{ A}$	-7	0.150	0.180	
Forward Transconductance (Note 3)	9 _{fs}	$V_{DS} = -5.0 \text{ V}, I_{D} = -3.0 \text{ A}$	(G)	7.0	-	S
Diode Forward Voltage (Note 3)	V _{SD}	$I_S = -0.9 \text{ A}, V_{GS} = 0 \text{ V}$		-0.8	-1.2	V
Pynamic (Note 4)		02 011	0	*		•
Total Gate Charge	Q_{g}	0, 9,) -	5.5	9.0	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = -4.0 \text{ V}, V_{GS} = -4.5 \text{ V},$ $I_{D} = -3.0 \text{ A}$	-	0.5	-	
Gate-Drain Charge	Q _{gd}		_	1.5	-	
Turn-On Delay Time	t _{d(on)}	(0,11,0)	_	10	15	ns
Rise Time	t _r	$V_{DD} = -4.0 \text{ V}, R_L = 4 \Omega$ $I_D \cong -1.0 \text{ A}, V_{GEN} = -4.5 \text{ V},$	-	45	70	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1.0 \text{ A}, V_{GEN} = -4.5 \text{ V},$ $R_G = 6 \Omega$	-	30	45	
Fall Time	St _f		_	10	15	1
Source-Drain Reverse Recovery Time	,t _m	I _F = -0.9 A, di/dt = 100 A/μs	_	30	60	1

- Surface Mounted on 1" x 1" FR4 Board.
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS



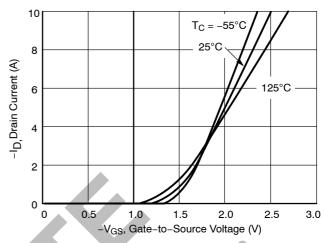


Figure 2. Transfer Characteristics

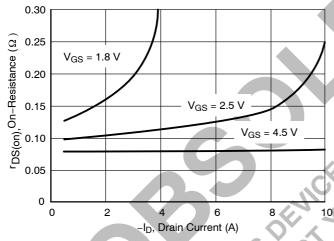


Figure 3. On-Resistance vs. Drain Current

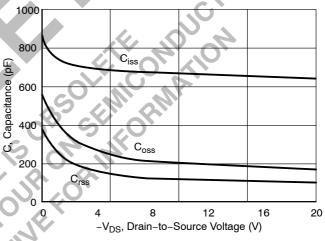


Figure 4. Capacitance

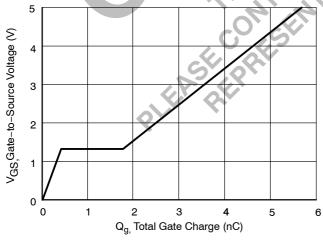


Figure 5. Gate Charge

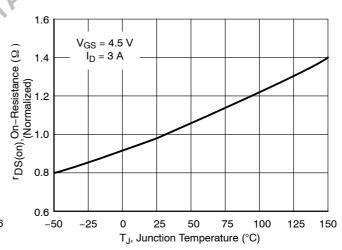


Figure 6. On-Resistance vs. **Junction Temperature**

TYPICAL ELECTRICAL CHARACTERISTICS

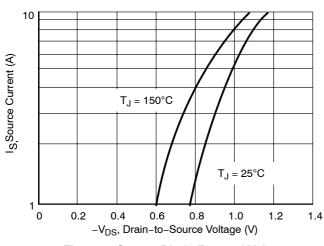


Figure 7. Source Diode Forward Voltage

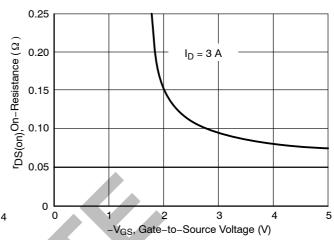
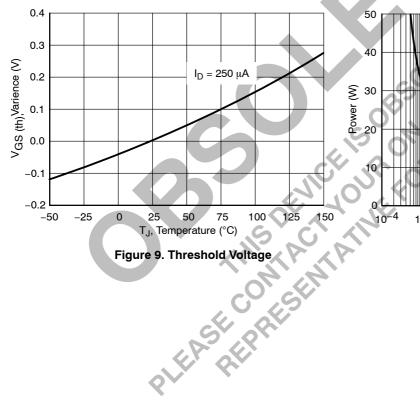


Figure 8. On-Resistance vs. Gate-to-Source Voltage



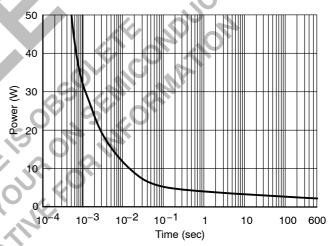


Figure 10. Single Pulse Power

TYPICAL ELECTRICAL CHARACTERISTICS

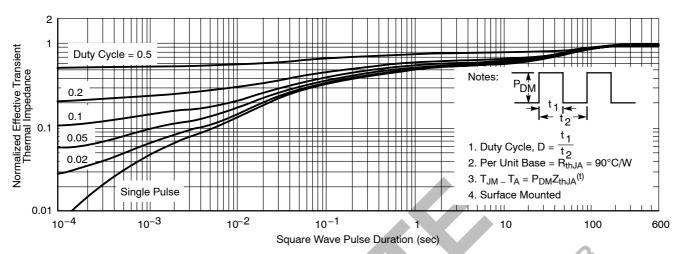
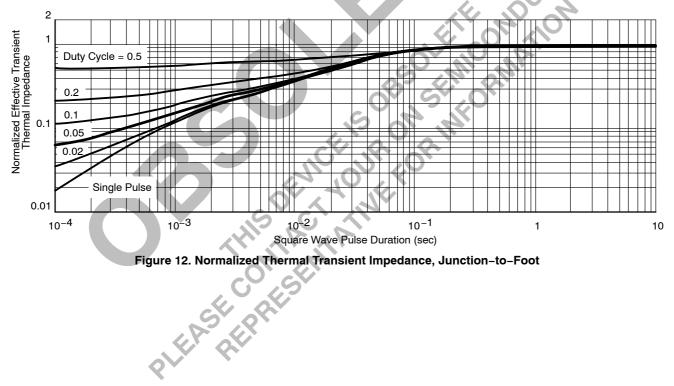


Figure 11. Normalized Thermal Transient Impedance, Junction-to-Ambient

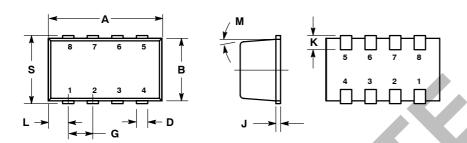


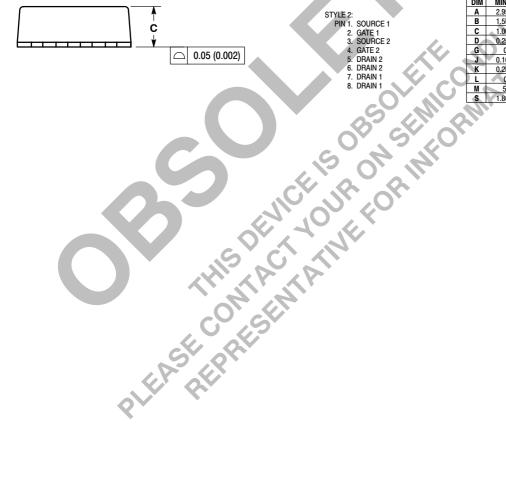
Notes



PACKAGE DIMENSIONS

ChipFET CASE 1206A-03 ISSUE D





STYLE 2: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2

NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: MILLIMETER.
 3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM
- PER SIDE.

 4. LEADFRAME TO MOLDED BODY OFFSET IN
 HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM
- DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE RURRS
- NO MOLD FLASH ALLOWED ON THE TOP AND
- BOTTOM LEAD SURFACE. 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.95	3.10	0.116	0.122	
В	1.55	1.70	0.061	0.067	
С	1.00	1.10	0.039	0.043	
D	0.25	0.35	0.010	0.014	
G	0.65 BSC		0.025 BSC		
J	0.10	0.20	0.004	0.008	
K	0.28	0.42	0.011	0.017	
L	0.55 BSC		0.022 BSC		
M (5°	NOM	5 ° NOM		
S	1.80	2.00	0.072	0.080	



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